

Docket No.: R2184.0282/P282

Examiner: Not Yet Assigned

(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Hirokazu Iwata et al.

Application No.: 10/765,502 Confirmation No.: 2556

Filed: January 28, 2004 Art Unit: N/A

For: METHOD OF GROWING GROUP III

NITRIDE CRYSTAL, GROUP III NITRIDE

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CRYSTAL GROWN THEREBY, GROUP III

NITRIDE CRYSTAL GROWING

APPARATUS AND SEMICONDUCTOR

DEVICE

CLAIM FOR PRIORITY AND SUBMISSION OF DOCUMENTS

MS Missing Parts
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicant hereby claims priority under 35 U.S.C. 119 based on the following prior foreign applications filed in the following foreign countries on the dates indicated:

Country	Application No.	Date
Japan	2003-019716	January 29, 2003
Japan	2003-071302	March 17, 2003
Japan	2003-081836	March 25, 2003
Japan	2004-011536	January 20, 2004
Japan	2004-012906	January 21, 2004
Japan	2004-013562	January 21, 2004

Application No.: 10/765,502 Docket No.: R2184.0282/P282

In support of this claim, a certified copy of each said original foreign application is filed herewith.

Dated: July 20, 2004

Respectfully submitted,

Mark J. Thronson

Registration No.: 33,082

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Attorney for Applicant



This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: January 29, 2003

Application Number: Japanese Patent Application

No.2003-019716

[ST.10/C]: [JP2003-019716]

Applicant(s): RICOH COMPANY, LTD.

December 1, 2003

Commissioner,

Japan Patent Office

Yasuo Imai (Seal)

Certificate No.2003-3098874

This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: March 17, 2003

Application Number: Japanese Patent Application

No.2003-071302

[ST.10/C]: [JP2003-071302]

Applicant(s): RICOH COMPANY, LTD.

December 1, 2003

Commissioner,

Japan Patent Office

Yasuo Imai (Seal)

Certificate No.2003-3098880

This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: March 25, 2003

Application Number: Japanese Patent Application

No.2003-081836

[ST.10/C]: [JP2003-081836]

Applicant(s): RICOH COMPANY, LTD.

December 1, 2003

Commissioner,

Japan Patent Office

Yasuo Imai (Seal)

Certificate No.2003-3098882



This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: January 20, 2004

Application Number: Japanese Patent Application

No.2004-011536

[ST.10/C]: [JP2004-011536]

Applicant(s): RICOH COMPANY, LTD.

March 3, 2004

Commissioner,

Japan Patent Office Yasuo Imai (Seal)

Certificate No.2004-3016100

This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: January 21, 2004

Application Number: Japanese Patent Application

No.2004-012906

[ST.10/C]: [JP2004-012906]

Applicant(s): RICOH COMPANY, LTD.

March 3, 2004

Commissioner,

Japan Patent Office Yasuo Imai (Seal)

Certificate No.2004-3016101

This is to certify that the annexed is a true copy of the following application as filed with this Office.

Date of Application: January 21, 2004

Application Number: Japanese Patent Application

No.2004-013562

[ST.10/C]: [JP2004-013562]

Applicant(s): RICOH COMPANY, LTD.

March 3, 2004

Commissioner,

Japan Patent Office Yasuo Imai (Seal)

Certificate No.2004-3016103